

Search Notes

Application/Control No.

10/781,370

Examiner

Lee Lum

Applicant(s)/Patent under
Reexamination

MIYAKAWA ET AL.

Art Unit

3611

SEARCHED

Class	Subclass	Date	Examiner
RESEARCH		6/12/06	ff-✓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR